





Center Macromolecular Structure Analysis: Equipment

Optical spectroscopy

FTIR spectrometer Vertex 70 (Bruker)

- DTGS and MCT detector
- accessories for reflection methods: ATR (also temperature-dependent), DRIFT, IRRAS (also heatable)
- variable temperature cell (SPECAC) for temperature-dependent measurements from RT up to 700 °C
- connected FTIR microscope (HYPERION) with XYcross table as well as programmable microscope hot stage and motorized knife edge aperture
- automatic search of spectra with different commercial-available and self-made data base libraries
- micro flow cell (AABSPEC mode #RA4000-EXP) for coupling of SEC/FTIR
- rheo-optical extension, rapid scan-mode

FTIR spectrometer Vertex 80v (Bruker)

- DTGS and MTC detector
- IRRAS (also heatable)
- external sample compartment: "Golden Gate Diamant ATR" (SPECAC) also temperaturedependent up to 200 °C
- integration module (Ulbricht sphere) for NIR with sample rotator for inhomogeneous samples

AFM-IR NanoIR 2 (Anasys/Bruker)

- OPO laser (3600-900 cm-1)
- contact mode

FT-IR Imaging system Spotlight 400 (PerkinElmer)

- microscope detector: MCT line detector (imaging) and MCT single detector
- spectrometer detector: LiTa03 MIR detector
- operating modes: single spectra/ spectral imaging in transmission and reflection, micro-ATR
- particle recognition software

RAMAN microscope alpha 300R+ (WITec)

- 532 nm and 785 nm laser, UHTS 300 spectrometer, EMCCD detector, heatable microscope stage,
- External fiber-coupled probe for in-situ measurements
- operating modes: single spectra, times series, spectral 2D/3D imaging, depth profiling, True
 Surface (topographic profiling), bright field and dark field, resolution: 240 nm laterally
- external particle recognition software GEPARD

RAMAN microscope inVia Qontor (Renishaw)

- 532 nm, 633 nm and 785 nm laser, detector: CCD
- operating modes: single spectra, surface montage, spectral 2D/3D imaging, Live Track[™], Focus Track[™], bright field and dark field, resolution: 240 nm laterally
- Internal and external particle recognition software

Particle software GEPARD

 for optical, FTIR- and Raman microscopes (Open Source software)









Chromatography, fractionation und light scattering

Asymmetrical flow-field flow fractionation (AF4)

- Eclipse 3 (Wyatt Technologies Corp., USA), organic/aqueous, with isocratic pump, autosampler, UV and RI detector, and DAWN EOS MALS detector (18 angles, Wyatt Technologies Corp., USA)
- Eclipse Dualtec (Wyatt Technologies Corp., USA), aqueous, with isocratic pump, autosampler, UV and T-rEX-RI-detector, and HELEOS II MALS detector (18 angles, with QELS-module), Thermos Pro temperature control unit (Wyatt Technologies Corp., USA)

Thermal field flow fractionation (ThFFF)

 Complete system TF2000 (Postnova) with RI and MALS detector (Postnova Analxtics GmbH, DE)

Size exclusion chromatography (SEC)

- different organic solvents (ambient and high temperature) and aqueous eluent (RT)
- Isocratic pumps, DA-, viscosity and RI detectors as well as autosamplers of 1100 and 1200 series (Agilent Technologies)
- Optilab T-rEX RI detector, TREOS and HELEOS II MALS detectors, QELS modules, Viscostar III (Wyatt Technologies Corp. USA)

Gas chromatography (GC)

- pyrolysis GC MS: pyroprobe (CDS Analytical Inc.) and GC7890A as well as MSD 5975C (Agilent Technologies)
- Headspace-GC-MS: Headspace sampler 7694, GC6890N and MSD 5973N (Agilent Technologies)

Batch characterization

- dynamic light scattering: DynaPro Nanostar (90°) from Wyatt Technologies Corp.
- Zeta potential measurements and dynamic light scattering: Zetasizer Nano Z (0-90 °C) with MPT-2 autotitrator (Malvern, UK)
- Microviscometer; Lovis (20-90 °C) (Anton Paar GmbH, Austria)

MALDI-TOF-MS

Autoflex Speed TOF/TOF System (Bruker)

 LC/MALDI-TOF-MS spray deposition interface ESAirD (BAM, Germany)

Elemental analysis

Elemental analyzer vario MICRO cube (Elementar)

Determination of H, C, N and S content

NMR spectroscopy

NMR spectrometer Avance III 500 (Bruker)

- 3 HF channels (X; ¹H/¹⁹F; Y)
- z gradient accessories, temperature control unit and autosampler
- QNP probe (¹H; ¹³C; ¹⁹F; ³¹P) with z gradient
- TBI probe (¹H; ¹³C; ³¹P-¹⁰⁹Ag) with z gradient
- BBO probe (¹H; ¹⁹F; ³¹P-¹⁰⁹Ag) with z gradient
- 10 mm triple resonance probe (¹H; X; ³¹P)
- 4 mm HRMAS probe (¹H; ¹³C) with z gradient

Optical characterization of thin films

Rotating compensator multi wavelength ellipsometer alpha-SE (J.A. Woollam Co. Inc.)

 spectral range 380-900 nm, incidence angle 65°,70° and 75°, with temperature and/or pH controlled insitu fluid cell

Rotating compensator multi wavelength ellipsometer M2000 UI (J.A. Woollam Co. Inc)

- spectral range 245-1700 nm
- incidence angle 45°-90°

Digital Multiple Wavelength Refractometer DSR Lambda (Schmidt + Haensch GmbH & Co.)

Müller matrix microscope (ACOM, University Nebraska-Lincoln)

- two rotating compensators,
- spectral range 250-1000 nm,
- single wavelength measurement modus, combinable with optically transparent microfluidic cells

Quartz crystal microbalance (Qsense, Biolin Scientific, Sweden)

 combinable with spectroscopic ellipsometry (alpha-SE, M2000 UI) or electrochemistry module

Thermal analysis

Thermobalance Q 5000 (TA Instruments)

 40 up to 1000 °C, with autosampler, nitrogen or air, optionally coupled to FTIR spectrometer Nicolet 380 (Thermo Electron) and to GC-MS (Agilent) via IST16 interface (SRA Instruments)

Dynamic differential calorimeter DSC Q 1000 (TA Instruments)

 -80 up to 400 °C, with autosampler, nitrogen, optionally temperature-modulated

Dynamic differential calorimeter Discovery DSC 2500 (TA Instruments)

 -120 up to 400 °C, with autosampler, nitrogen and air, optionally temperature-modulated, with RCS120 cooling system

Contact

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